Search Notes				

Application No.	Applicant(s)		
10/038,084	FALSTER, ROBERT J.		
Examin r	Art Unit		
Anh D. Mai	2814		

0545					
SEARCHED					
Subclass	Date	Examiner			
		-			
	<u> </u>	SEARCHED Subclass Date			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCI	TES H STRATEGY)		
	DATE			
EAST (all): * CZ and wafer and vacancy and defect	1/15/2004	A.M		
		-		